

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination LEHIKONEN ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2005/0073443 A1	04-2005	Sheha et al.	340/995.1
	B	US-2003/0233422 A1	12-2003	Csaszar et al.	709/206
	C	US-2002/0164995 A1	11-2002	Brown et al.	455/456
	D	US-2004/0235520 A1	11-2004	Cadiz et al.	455/557
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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